

Search Notes

Application/Control No.

09/661,806

Examiner

Sunray Chang

Applicant(s)/Patent under
Reexamination

HASEGAWA ET AL.

Art Unit

2121

SEARCHED

Class	Subclass	Date	Examiner
703	2	8/7/2005	SC
345	434,441	8/7/2005	SC
345	419-421	8/7/2005	SC
345	431,426	8/7/2005	SC

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner
703	2	8/7/2005	SC
345	419-441	8/7/2005	SC

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST (USPAT, US_PGPUB, JPO, EPO, DERWENT, IBM_TDB)	8/7/2005	SC